

<b>Notice of References Cited</b>	Application/Control No. 10/585,612	Applicant(s)/Patent Under Reexamination MIYAHARA, SEIICHIRO	
	Examiner DANIELLE HENKEL	Art Unit 1775	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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